

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10588871	SAITO ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Johnson, Ryan J	2817

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
331	117R,117FE,117D,107SL,167,185,186,166,173	12/4/2007	Ryan Johnson

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See EAST history	12/4/2007	Ryan Johnson
IEEE search	12/4/2007	Ryan Johnson
Emailed Joseph Chang	12/4/2007	Ryan Johnson

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>